Special Issue

Fog Analytics for Real Time IoT Applications

Message from the Guest Editors

This special issue aims to bring together researchers from both academia and industry in the application of novel methods for IoT fog analytics for real-time or mission-critical systems. **Topics:** The main topics of this special session include, but are not limited to, the following:

- Fog analytics for real time IoT applications
- Compact machine learning for real-time analytics
- Intelligent data synchronization and updating between IoT Sensor Datacentres
- Intelligent pricing mechanisms for Datacentres
- Data Analytics middleware for real-time applications
- Case studies for Fog data analytics
- Vehicular Computing for Smart Cities
- AI-enabled Big Data for Mission-Critical applications
- Optimization in Fog Computing/analytics
- Application of Fog Analytics for real world applications

Guest Editors

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Dr. Mukesh Prasad

Deadline for manuscript submissions

closed (30 June 2022)

Sensors

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About the Journal

Message from the Editor-in-Chief

Sensors is a leading journal devoted to fast publication of the latest achievements of technological developments and scientific research in the huge area of physical, chemical and biochemical sensors, including remote sensing and sensor networks. Both experimental and theoretical papers are published, including all aspects of sensor design, technology, proof of concept and application. Sensors organizes Special Issues devoted to specific sensing areas and applications each year.

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